## Homework 4 Solutions:

PROBLEM 1: An abrupt Si $p^{+}-n$ diode has $N_{D}=10^{16} \mathrm{~cm}^{-3}$ on the $n$ side and $N_{A}=10^{17} \mathrm{~cm}^{-3}$ on the $p$ side. For Si at room temperature, $E_{G}=1.1 \mathrm{eV}, N_{C}=2.8 \times 10^{19} \mathrm{~cm}^{-3}$, and $N_{V}=1.8 \times 10^{19} \mathrm{~cm}^{-}$ ${ }^{3}$. Assume the minority carrier lifetime is $8 \mu \mathrm{~s}$ (for both electrons and holes), the electron mobility is $1400 \mathrm{~cm}^{2} / \mathrm{V} \cdot \mathrm{s}$, and the hole mobility is $500 \mathrm{~cm}^{2} / \mathrm{V} \cdot \mathrm{s}$.

PART A: Find the depletion region width under zero bias on the $p$-side ( $w_{p o}$ ) and on the $n$-side $\left(\mathrm{w}_{\mathrm{n} 0}\right)$, and the total depletion width $\mathrm{w}_{\text {tot }, 0}$.

$$
\begin{gathered}
V_{0}=\frac{k T}{q} \ln \left(\frac{N_{a} N_{d}}{n_{i}^{2}}\right)=0.0259 * \ln \left(\frac{10^{33}}{2.25 * 10^{20}}\right)=0.754 \mathrm{~V} \\
W_{t o t}\left(V_{A}\right)=\sqrt{\left(\frac{2 \epsilon}{q}\left(\frac{1}{N_{a}}+\frac{1}{N_{d}}\right)\left(V_{o}-V_{A}\right)\right)} \\
\epsilon_{S i}=11.7 \epsilon_{o}=11.7 * 8.85 * 10^{-14}=1.04 * 10^{-12} \mathrm{~F} / \mathrm{cm} \\
W_{t o t}=\sqrt{\frac{2 * 1.04 * 10^{-12} \mathrm{~F} / \mathrm{cm}}{1.6 * 10^{-19} \mathrm{C}} *\left(\frac{1}{10^{16} \mathrm{~cm}}{ }^{-3}+\frac{1}{10^{17} \mathrm{~cm}}{ }^{-3}\right) *\left(V_{o}-V_{A}\right)} \\
=\left(3.77 * 10^{-5} \mathrm{~cm} \cdot V^{-1 / 2}\right) * \sqrt{V_{o}-V_{A}}=\left(0.377 \mu m \cdot V^{-1 / 2}\right) * \sqrt{V_{o}-V_{A}}
\end{gathered}
$$

At $V_{A}=0$ :

$$
\begin{aligned}
& W_{t o t}(0 \mathrm{~V})=\left(0.377 \mu m \cdot V^{-\frac{1}{2}}\right) \sqrt{0.754 V}=0.33 \mu \mathrm{~m} \\
& x_{p}=\frac{W * N_{d}}{N_{a}+N_{d}}=0.33 * \frac{10^{16}}{1.1 * 10^{17}}=0.03 \mu m \\
& x_{n}=\frac{W * N_{a}}{N_{a}+N_{d}}=0.33 * \frac{10^{17}}{1.1 * 10^{17}}=0.30 \mu m
\end{aligned}
$$

PART B: If a forward bias of 0.2 V is applied, find the resulting depletion widths ( $w_{p}, w_{n}$, and $w_{\text {tot }}$ ), the electron current density $J_{n}$ through the depletion region, the hole current density $J_{p}$ through the depletion region, and the total current density $J_{\text {tot }}$ through the diode.

At $V_{A}=0.2 \mathrm{~V}$ :

$$
\begin{aligned}
& W_{t o t}(0.2 \mathrm{~V})=\left(0.377 \mu m \cdot V^{-\frac{1}{2}}\right) \sqrt{0.754 \mathrm{~V}-0.2 \mathrm{~V}}=0.28 \mu \mathrm{~m} \\
& x_{p}=\frac{W * N_{d}}{N_{a}+N_{d}}=0.28 * \frac{10^{16}}{1.1 * 10^{17}}=0.026 \mu \mathrm{~m} \\
& x_{n}=\frac{W * N_{a}}{N_{a}+N_{d}}=0.28 * \frac{10^{17}}{1.1 * 10^{17}}=0.255 \mu \mathrm{~m}
\end{aligned}
$$

$$
\begin{array}{cc}
J_{n}=\frac{q D_{n} n_{p}}{L_{n}}\left(e^{q V_{A} / k T}-1\right) & J_{p}=\frac{q D_{p} p_{n}}{L_{p}}\left(e^{q V_{A} / k T}-1\right) \\
D_{n}=\frac{k T}{q} \mu_{n}=36.3 \frac{\mathrm{~cm}^{2}}{s} & D_{p}=\frac{k T}{q} \mu_{p}=12.95 \frac{\mathrm{~cm}^{2}}{\mathrm{~s}} \\
L_{n}=\sqrt{D_{n} \tau_{n}}=1.70 * 10^{-2} \mathrm{~cm} & L_{p}=\sqrt{D_{p} \tau_{p}}=1.02 * 10^{-2} \mathrm{~cm} \\
n_{p}=\frac{n_{i}^{2}}{N_{A}}=2.25 * 10^{3} \mathrm{~cm}^{-3} & p_{n}=\frac{n_{i}^{2}}{N_{D}}=2.25 * 10^{4} \mathrm{~cm}^{-3}
\end{array}
$$

$$
\begin{aligned}
& J_{n}=\left(7.7 \times 10^{-13} \mathrm{~A} / \mathrm{cm}^{2}\right)\left(e^{.2 / .0259}-1\right)=1.7 \times 10^{-9} \mathrm{~A} / \mathrm{cm}^{2} \\
& J_{p}=\left(4.6 \times 10^{-12} \mathrm{~A} / \mathrm{cm}^{2}\right)\left(e^{.2 / .0259}-1\right)=1.02 \times 10^{-8} \mathrm{~A} / \mathrm{cm}^{2} \\
& J_{\text {tot }}=J_{n}+J_{p}=1.2 \times 10^{-8} \mathrm{~A} / \mathrm{cm}^{2}
\end{aligned}
$$

Problem 2:

$$
\mathbf{W}=A * \sqrt{\frac{N_{A}+N_{D}}{N_{A} N_{D}}} \quad A=\sqrt{\frac{2 \epsilon}{q}\left(V_{0}-V_{A}\right)}
$$

PART A:
In Problem 1, $N_{D}=0.1 N_{A}$.

$$
\begin{aligned}
& \text { If } \boldsymbol{N}_{D, n e w}=2 N_{D} \rightarrow N_{D, n e w}=\mathbf{0 . 2} N_{A} \\
& W=\mathrm{A} * \sqrt{\frac{1.1 \mathrm{~N}_{\mathrm{A}}}{0.1 N_{A}^{2}}} \quad W_{\text {new }}=A * \sqrt{\frac{1.2 N_{A}}{0.2 N_{A}^{2}}} \\
& \frac{W_{\text {new }}}{W}=\sqrt{\frac{6}{11}}=73.9 \% \\
& \frac{\Delta W}{W}=-26.1 \% \\
& \text { If } \boldsymbol{N}_{A, n e w}=2 \boldsymbol{N}_{A} \rightarrow \boldsymbol{N}_{A, n e w}=\mathbf{2 0 N _ { D }} \\
& W=\mathrm{A} * \sqrt{\frac{11 \mathrm{~N}_{\mathrm{D}}}{10 N_{D}^{2}}} \quad W_{\text {new }}=A * \sqrt{\frac{21 N_{D}}{20 N_{D}^{2}}} \\
& \frac{W_{\text {new }}}{W}=\sqrt{\frac{21}{22}}=97.7 \% \\
& \frac{\Delta W}{W}=-2.3 \%
\end{aligned}
$$

PART B:
N doping is increased by a factor of 2

$$
\begin{gathered}
\mathrm{P}_{\text {new }}=\frac{1}{2} P_{n}=1.125 * 10^{4} \mathrm{~cm}^{-3} \\
\mathrm{~J}=\mathrm{q}\left(4.8 * 10^{6}+14.325 * 10^{6}\right)=19.125 * 10^{6} * q=3.06 * 10^{-16} \mathrm{~A} / \mathrm{cm}^{2} \\
\frac{\mathrm{~J}_{\text {new }}}{\mathrm{J}}=\frac{3.06}{5.352}=57.2 \% \\
\frac{\Delta \mathrm{~J}}{\mathrm{~J}}=-42.8 \%
\end{gathered}
$$

$$
\begin{gathered}
\text { P doping is increased by a factor of } 2 \\
\mathrm{~N}_{\text {new }}=\frac{1}{2} n_{p}=1.125 * 10^{3} \mathrm{~cm}^{-3} \\
\mathrm{~J}=\mathrm{q}\left(2.4 * 10^{6}+28.65 * 10^{6}\right)=31.05 * 10^{6} * q=4.968 * 10^{-12} \mathrm{~A} / \mathrm{cm}^{2} \\
\frac{\mathrm{~J} \text { new }}{\mathrm{J}}=\frac{4.968}{5.352}=92.9 \% \\
\frac{\Delta \mathrm{~J}}{\mathrm{~J}}=-7.1 \%
\end{gathered}
$$

## PART C:

As seen above, varying the doping on the heavily doped side only causes very small changes in the depletion width and current density in the diode, whereas varying the doping on the lightly doped side causes much larger variations in the resulting depletion width and current density.

Problem 3: In a $\mathrm{P}^{+} \mathrm{N}$ junction, the hole diffusion current in the neutral $n$ material is given by Eq. 5.32 in Streetman. What are the electron diffusion and electron drift components of current at point $x_{n}$ in the neutral $n$ region?

$$
\begin{gathered}
I_{p}\left(x_{n}\right)=\frac{q A D_{p}}{L_{p}} * p_{n} e^{q V / k T} e^{-x_{n} / L_{p}} \quad \text { for } V \gg \frac{K T}{q} \\
I_{t o t} \cong I_{p}\left(x_{n}=0\right)=\frac{q A D_{p}}{L_{p}} p_{n} e^{q V / k T}
\end{gathered}
$$

Assuming space charge neutrality, the excess hole distribution is equal to the excess electron distribution:

$$
\begin{gathered}
\delta n\left(x_{n}\right)=\delta p\left(x_{n}\right) \\
I_{n, d i f f}\left(x_{n}\right)=q A D_{n} \frac{d \delta n}{d x_{n}}=\frac{q A D_{n}}{L_{p}} p_{n} e^{q V / k T} e^{-x_{n} / L_{p}}
\end{gathered}
$$

Since $I_{\text {tot }}$ is constant we have :

$$
\begin{gathered}
I_{n, \text { drift }}\left(x_{n}\right)=I_{t o t}-I_{n, \text { diff }}\left(x_{n}\right)-I_{p}\left(x_{n}\right) \\
I_{n, \text { drift }}\left(x_{n}\right)=\frac{q A p_{n}}{L_{p}} e^{\frac{q V}{K T}}\left[D_{p}\left(1-e^{-\frac{x_{n}}{L_{p}}}\right)+D_{n} e^{-\frac{x_{n}}{L_{p}}}\right]
\end{gathered}
$$

Problem 4: Assume that a $\mathrm{P}^{+} \mathrm{N}$ diode is built with a quasi-neutral $n$ region having a width I which is smaller than the hole diffusion length $\left(I<L_{p}\right)$. This is a so-called narrow base diode. Since for this case holes are injected into a shorter $n$ region under forward bias, we cannot use the boundary condition $\delta p\left(x^{\prime}=\infty\right)=0$ as in Eq. 4-35 in Streetman. Instead, our boundary condition becomes $\delta p\left(x^{\prime}=l\right)=0$.

Part A: Solve the diffusion equation for this case to obtain $\delta p\left(x^{\prime}\right)=\frac{\Delta p_{n}\left[e^{\frac{l-x^{\prime}}{L_{P}}}-e^{-\frac{l-x^{\prime}}{L_{p}}}\right]}{e^{\frac{l}{L_{p}}}-e^{-\frac{l}{L_{p}}}}$

$$
\begin{gathered}
\frac{d^{2} \delta p}{d\left(x^{\prime}\right)^{2}}=\frac{\delta p\left(x^{\prime}\right)}{L_{p}^{2}} \\
\delta p\left(x^{\prime}\right)=C e^{-\frac{x^{\prime}}{L_{p}}}+D e^{\frac{x^{\prime}}{L_{p}}}
\end{gathered}
$$

Most of the holes will diffuse across the narrow $n$ region without recombining. At the contact:

$$
\begin{gathered}
\text { At } x^{\prime}=l: \quad \delta p=0 \\
\text { At } x^{\prime}=0: \delta p=\Delta p_{n} \\
\Delta p_{n}=C+D \\
0=C e^{-\frac{l}{L_{p}}}+D e^{\frac{l}{L_{p}}}
\end{gathered}
$$

## Solving :

$$
\begin{gathered}
C=\frac{\Delta p_{n} e^{\frac{l}{L_{p}}}}{e^{\frac{l}{L_{p}}}-e^{-\frac{l}{L_{p}}}} \\
D=\Delta p_{n}-C=-\frac{\Delta p_{n} e^{-\frac{l}{L_{p}}}}{e^{\frac{l}{L_{p}}}-e^{-\frac{l}{L_{p}}}} \\
\text { plugging C and D: } \\
\delta p\left(x^{\prime}\right)=\frac{\Delta p_{n}\left[e^{\frac{l-x^{\prime}}{L_{p}}}-e^{\frac{-l-x^{\prime}}{L_{p}}}\right]}{e^{\frac{l}{L_{p}}}-e^{-\frac{l}{L_{p}}}}
\end{gathered}
$$

Part B: If $\mid \ll L_{p}$ show $\delta p\left(x^{\prime}\right)=\Delta p_{n}\left(1-\frac{x \prime}{l}\right)$

$$
\begin{gathered}
e^{x}=1+x+\frac{x^{2}}{2!}+\frac{x^{3}}{3!} \\
e^{-x}=1-x+\frac{x^{2}}{2!}-\frac{x^{3}}{3!} \\
e^{x}-e^{-x}=2\left[2+\frac{x^{3}}{3!}+\cdots\right] \\
e^{\frac{l}{L_{p}}}-e^{\left(-\frac{l}{L_{p}}\right)}=2\left[\frac{l}{L_{p}}\right]=2 \quad \operatorname{since} \frac{l}{L_{p}} \ll 1 \quad \frac{x^{3}}{3!} \ll x \\
e^{\frac{l-x \prime}{L_{p}}}-e^{\left(\frac{-\left(l-x^{\prime}\right)}{L_{p}}\right)}=2\left[\frac{l-x^{\prime}}{L_{p}}\right] \\
\delta p\left(x^{\prime}\right)=\Delta p_{n}\left[\frac{l-x^{\prime}}{l}\right]=\Delta p_{n}\left[1-\frac{x^{\prime}}{l}\right]
\end{gathered}
$$

